_	
σ	
α	ì
Ø	į
_	
7	į
-	
Ŀ	
-	
Q	
_	

John Zhong

EAST SEARCH

5/15/04

/ #	Hits	Search String Databases
[1	2590	((integrated or digital) adj circuit§1) with (simulation or (model near2 check\$3)) USPAT, US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
7	187	(((integrated or digital) adj circuit\$1) with (simulation or (model near2 check\$3))) and (reduc\$4 USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
ខា	181	(((integrated or digital) adj circuit\$1) with (simulation or (model near2 check\$3))) and ((encod\$USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
L 5	36	(((integrated or digital) adj circuit\$1) with (simulation or (model near2 check\$3))) and (reduc\$ USPAT, US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
9 7	45	(((integrated or digital) adj circuit\$1) with (simulation or (model near2 check\$3))) and (identic USPAT, US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
77	0	(((integrated or digital) adj circuit\$1) with (simulation or (model near2 check\$3))) and (encod\$ USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
F 8	0	(((integrated or digital) adj circuit\$1) with (simulation or (model near2 check\$3))) and (encod\$ USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
67	26	(((integrated or digital) adj circuit\$1) with (simulation or (model near2 check\$3))) and USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
L10	4	(((integrated or digital) adj circuit\$1) with (simulation or (model near2 check\$3))) and USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
11	32	((((integrated or digital) adj circuit\$1) with (simulation or (model near2 check\$3))) and (identic USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
L12	17	(((integrated or digital) adj circuit\$1) with (simulation or (model near2 check\$3))) and (identica USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
L13	-	(((integrated or digital) adj circuit\$1) with (simulation or (model near2 check\$3))) and ((encod\$USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
L14	0	(((integrated or digital) adj circuit\$1) with (simulation or (model near2 check\$3))) and (ternary USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
L15	7	(((integrated or digital) adj circuit\$1) with (simulation or (model near2 check\$3))) and (symbol USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
L16	131	(identical near2 (component\$1 or subcircuit\$1)) with (encod\$3 or decod\$3)
L4	6	((identical near2 (component\$1 or subcircuit\$1)) with (encod\$3 or decod\$3)) and (reduc\$4 w USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
L17	16	((identical near2 (component\$1 or subcircuit\$1)) with (encod\$3 or decod\$3)) same (port or n. USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
L18	3403	((integrated or digital) adj circuit\$1) and (identical near2 (component\$1 or subcircuit\$1)) USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
1 20	481	(((integrated or digital) adj circuit\$1) and (identical near2 (component\$1 or subcircuit\$1))) and USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
[2]	120	(((integrated or digital) adj circuit\$1) and (identical near2 (component\$1 or subcircuit\$1))) an USPAT, US-PGPUB; EPO, JPO, DERWENT, IBM_TDB
122	-	(((integrated or digital) adj circuit\$1) and (identical near2 (component\$1 or subcircuit\$1))) and USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
L23	7	((((integrated or digital) adj circuit\$1) and (identical near2 (component\$1 or subcircuit\$1))) an USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
L25	0	(((integrated or digital) adj circuit\$1) and (identical near2 (component\$1 or subcircuit\$1))) and USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
L26	-	(((integrated or digital) adj circuit\$1) and (identical near2 (component\$1 or subcircuit\$1))) and USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
L27	7	(((integrated or digital) adj circuit\$1) and (identical near2 (component\$1 or subcircuit\$1))) and USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
L31	7	((((integrated or digital) adj circuit\$1) and (identical near2 (component\$1 or subcircuit\$1))) an USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB
L32	42	(((integrated or digital) adj circuit\$1) and (identical near2 (component\$1 or subcircuit\$1))) and USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
L33	4	(((integrated or digital) adj circuit\$1) with (simulation or (model near2 check\$3))) and (symboli USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB
09/774,989		John Zhong

EAST SEARCH

5/15/04

Results of search set L24:(processor\$1 or "processing unit") with ((estimat\$3 or determin\$5 or calculat\$3) near2 electromagnetic)

Document Kind Codes Title
US 20040070772 A1 Parametric profiling using optical spectroscopic systems

Abstract

20040304 60/285 20040205 703/17 20040122 345/506 20030904 702/22 20030731 703/21 2003020 430/30 2003020 430/30 20030130 430/3 20030130 430/5 20021114 235/379 20021017 703/17 20021017 703/17 20021017 703/17 20021017 703/17 20020124 330/2 20020124 330/2 20020120 330/2 20020115 330/2 20020115 330/2 20020116 703/14 2003050 345/600 20020110 330/2 200201112 330/2 200201112 330/2 20020112 330/2 200201112 330/2 200201112 330/2 200201113 330/2 20020113 330/2 200201113 330/2 200201113 330/2 200201113 330/2 200201113 330/2 200201113 330/2 200201113 330/2 200201113 330/2 20020113 330/2 200201113 330/2 200201113 330/2 200201113 330/2 200201113 330/2 200201113 330/2 200201113 330/2 200201113 330/2 200201113 330/2 200201113 330/2 200201113 330/2 20020111 363/126 19930601 323/312	19740115 219/626
Scal Non Non Non Non Non Non Non Non Non Non	SOLID STATE INDUCTION COOKING SYSTEMS FOR RANGES AND SURFACE COOKING
US 20040040286 A1 US 20040012600 A1 US 20030167135 A1 US 20030144828 A1 US 20030144828 A1 US 20030115030 A1 US 20030034570 A1 US 20030034570 A1 US 20030022075 A1 US 20030022075 A1 US 20020147555 A1 US 20020147555 A1 US 200201404 A1 US 20020140566 B1 US 6697436 B1 US 6387184 B1 US 6381366 B1 US 63821366 B1 US 63821366 B1 US 63821366 B1 US 63821366 B1 US 6381343 A US 5687068 A US 5216354 A	US 3786219 A